

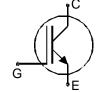
## IGBT<sup>3</sup> Chip

#### **FEATURES:**

- 1700V Trench + Field Stop technology
- low turn-off losses
- short tail current
- positive temperature coefficient
- · easy paralleling

## This chip is used for:

power module



## **Applications:**

drives

Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code	
SIGC68T170R3	1700V	50A	8.23 x 8.25 mm <sup>2</sup>	sawn on foil	Q67050- A4147-A001	

#### **MECHANICAL PARAMETER:**

Raster size	8.23 x 8.25				
Emitter pad size	4 x ( 2.94 x 2.97 )				
Gate pad size	1.18 x 1.09				
Area total / active	67.9 / 49.9	mm <sup>2</sup>			
Thickness	190	μm			
Wafer size	150	mm			
Flat position	90	grd			
Max.possible chips per wafer	204 pcs				
Passivation frontside	Photoimide				
Emitter metalization	3200 nm AlSiCu				
Collector metalization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	Al, <500μm				
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



#### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T <sub>j</sub> =25 °C	V <sub>CE</sub>	1700	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	А
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	150	Α
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55 <b>+</b> 150	°C

<sup>1)</sup> depending on thermal properties of assembly

## STATIC CHARACTERISTICS (tested on chip), $T_j$ =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
- urumeter			min.	typ.	max.	01
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{GE}$ =0 $V$ , $I_{C}$ = 2.5 $mA$	1700			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =50A	1.6	2	2.4	V
Gate-emitter threshold voltage	V <sub>GE(th)</sub>	I <sub>C</sub> =2mA , V <sub>GE</sub> =V <sub>CE</sub>	5.2	5.8	6.4	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =1700V , V <sub>GE</sub> =0V			3	μA
Gate-emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> =0V , V <sub>GE</sub> =20V			600	nA
Integrated gate resistor	R <sub>Gint</sub>			9.5		Ω

## **ELECTRICAL CHARACTERISTICS** (tested at component):

Parameter	Symbol	Conditions	Value			Unit
raiailletei			min.	typ.	max.	
Input capacitance	Ciss	V <sub>CE</sub> =25V,		4408		pF
Output capacitance	Coss	$V_{GE}=0V$ ,		183		
Reverse transfer capacitance	Crss	f=1MHz		146		

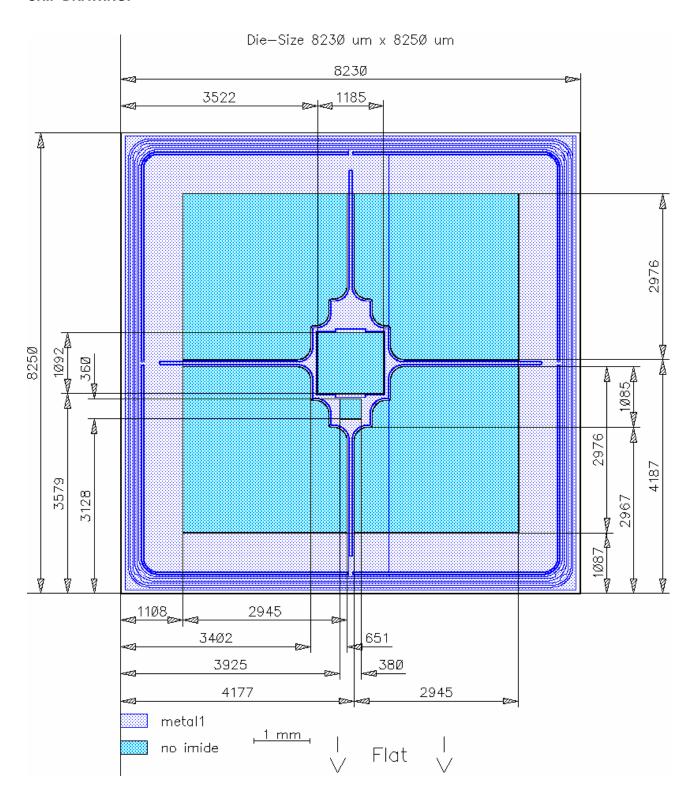
## SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol	Conditions 1)	Value			Unit
- arameter			min.	typ.	max.	
Turn-on delay time	$t_{d(on)}$	<i>T</i> <sub>j</sub> =125°C		400		ns
Rise time	$t_{r}$	V <sub>CC</sub> =900V,		50		
Turn-off delay time	$t_{d(off)}$	I <sub>C</sub> =50A, V <sub>GE</sub> =-15/15V,		800		
Fall time	$t_{f}$	$R_{\rm G}$ = 10.2 $\Omega$		300		

<sup>&</sup>lt;sup>1)</sup> values also influenced by parasitic L- and C- in measurement and package.



#### **CHIP DRAWING:**





# This chip data sheet refers to the device data sheet DESCRIPTION: AQL 0,65 for visual inspection according to failure catalog Electrostatic Discharge Sensitive Device according to MIL-STD 883

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